

**Notice of References Cited**

		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		09/826,702	CHUNG, DAE-SUK	
Examiner		Art Unit		Page 1 of 1
Angel L. Casiano		2182		

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0138648 A1	09-2002	Liu, Kuang-Chih	709/245
	B	US-6,483,525 B1	11-2002	Tange, Akira	345/765
	C	US-6,272,135 B1	08-2001	Nakatsugawa, Yoshinori	370/390
	D	US-6,212,565 B1	04-2001	Gupta, Amit	709/229
	E	US-6,061,738	05-2000	Osaku et al.	709/245
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2001175595 A	06-2001	Japan	OSHIMI, AKIE	G06F 15/00
	O	KR 2001040075 A	05-2001	Korea, Republic	CHAE et al.	H04L 12/28
	P	EP 1063827 A2	12-2000	European Patent	GOUDREAU, MARK	H04L 29/06
	Q	WO 200108358 A1	02-2001	World Intellect	TODOKORO, G	H04L 12/56
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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